

**Search Notes**

Application/Control No.

10/693,640

Examiner

Quynh H. Nguyen

Applicant(s)/Patent under  
Reexamination

FINK ET AL.

Art Unit

2642

**SEARCHED**

Class	Subclass	Date	Examiner
379	93.17 93.23 265.01 265.02 265.03	6/15/2005	QN
379	265.11 309	6/15/2005	QN
above updated		12/19/05	QN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
379	265.01 265.02 265.03 265.11 309	12/19/05	QN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
searched: east	6/15/2005	QN
inventor searched through PALM database	6/15/2005	QN
Consulted with Benny Tieu and Hector Agdeppa	12/14/05	QN
Interference search history print out	12/19/05	QN